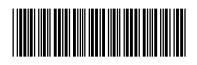
Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10572752	NAKAMURA ET AL.
Examiner	Art Unit
Jennifer F Hu	4158

SEARCHED				
Class	Subclass	Date	Examiner	
343	788	11/13/2007	Jennifer F.	
			Chang	
343	787	11/19/2008	Jennifer F.	
			Chang	

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Search History	11/13/2007	Jennifer F. Chang		
Inventor Search in eDAN	11/13/2007	Jennifer F. Chang		
EAST Search History	6/5/2008	Jennifer F. Chang		

INTERFERENCE SEARCH			
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